

SANYO Semiconductors DATA SHEET

LA9247T — Monolithic Linear IC CD-ROM Digital Servo RF IC

Overview

The LA9247T is a CD-ROM digital servo RF IC that supports speeds up to 52×.

Functions

- RF amplifier (with AGC), RF gain amplifier (supports playback of CD-RW discs).
- RF equalizer circuit (with 7 modes), RF hold function.
- PH/BH detection, FE amplifier, REFL amplifier, TE amplifier.
- Servo signal VCA circuit (balance adjustment, SGC adjustment), midpoint servo (CSS) amplifier.
- APC circuit (with laser power amplifier function), sleep function.

Specifications

Maximum Ratings at Ta = 25°C, Pin 4, 31 = GND

Parameter	Symbol	Conditions	Ratings	Unit
Maximum supply voltage	V _{CC} max		7.0	V
Allowable power dissipation	Pd max		300	mW
Operating temperature	Topr		-25 to +70	°C
Storage temperature	Tstg		-40 to +150	°C

Operating Conditions at $Ta = 25^{\circ}C$, Pin 4, 31 = GND

Parameter	Symbol	Conditions	Ratings	Unit
Recommended operating voltage	Vcc		5.0	V
Allowable operating voltage range	V _{CC} op		4.5 to 5.5	V

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$\textbf{Operating Characteristics} \ at \ Ta=25^{\circ}C, \ V_{CC} \ (pin\ 23,\ 34)=5V, \ V_{CC}3 \ (pin\ 6)=3.3V, \ GND \ (pin\ 4,\ 31)=0 \ V_{CC} \ (pin\ 6)=3.3V, \ GND \ (pin\ 4,\ 31)=0 \ V_{CC} \ (pin\ 6)=3.3V, \ GND \ (pin\ 4,\ 31)=0 \ V_{CC} \ (pin\ 6)=3.3V, \ GND \ (pin\ 4,\ 31)=0 \ V_{CC} \ (pin\ 6)=3.3V, \ GND \ (pin\ 4,\ 31)=0 \ V_{CC} \ (pin\ 6)=3.3V, \ GND \ (pin\ 6)=3.3V, \ (pin\ 6)=3.2V, \ (pin\ 6)$

Parameter	Symbol	Conditions		Ratings		Unit	
raiametei	Symbol	Conditions	min	typ	max	Utilit	
Current drain	l _{CC}	No signal	24	36	48	mA	
Current drain (sleep mode)	I _{CC} S	No signal, EQS = 0V	1.5	5	8.5	mA	
Reference voltage	VR		2.3	2.5	2.7	V	
Reference voltage	VR2		1.5	1.65	1.8	V	
Preamp offset	RFAOost	The difference with VR for RFAO	-120	0	120	mV	
RF no signal voltage	RFSM	RFIN = VR	1.6	1.9	2.2	V	
RF gain (min)	RFG1	GHS = 0V	0	2.5	5.0	dB	
RF gain (max)	RFG2	GHS = 0V	14.5	16.5	18.5	dB	
RF gain (UP)	RFRW	GHS = 3.3V	+10.5	+14.0	+17.5	dB	
RFEQ - normal	RFEQN	The difference in RFSM when RFIN is $100mVp-p$, $f = 1MHz$ and $100mVp-p$, $f = 100kHz$. EQS = $3.3V$	+0.5	+2.75	+5.0	dB	
RFEQ-CAV1	RFEQ1	The difference in RFSM when RFIN is $100mVp-p$, $f = 2.4MHz$ and $100mVp-p$, $f = 100kHz$. EQS = $2.7V$	+0.5	+2.75	+5.0	dB	
RFEQ-CAV2	RFEQ2	The difference in RFSM when RFIN is 100mVp-p, f = 4.3MHz and 100mVp-p, f = 100kHz. EQS = 2.2V	+0.5	+2.75	+5.0	dB	
RFEQ-CAV3	RFEQ3	The difference in RFSM when RFIN is 100mVp-p, f = 8MHz and 100mVp-p, f = 100kHz. EQS = 1.8V	+0.5	+2.75	+5.0	dB	
RFEQ-CAV4	RFEQ4	The difference in RFSM when RFIN is 100mVp-p, f = 12MHz and 100mVp-p, f = 100kHz. EQS = 1.5V	+0.5	+2.75	+5.0	dB	
RFEQ-CAV5	RFEQ5	The difference in RFSM when RFIN is 100mVp-p, f = 24MHz and 100mVp-p, f = 100kHz. EQS=1.1V	+0.5	+2.75	+5.0	dB	
RFEQ-CAV6	RFEQ6	The difference in RFSM when RFIN is 100mVp-p, f = 35MHz and 100mVp-p, f = 100kHz. EQS = 0.7V	+0.5	+2.75	+5.0	dB	
RF hold	RFHLD	RFIN: 1.5Vp-p, f = 100kHz, RHLD = 3.3V	-13.5	-11.0	-8.5	dB	
PH	PH	RFIN = VR	0.65	0.9	1.15	V	
ВН	BH	RFIN = VR	0.65	0.9	1.15	V	
ΔBHL	ΔBHL	RFIN = VR, Δ BHL = BH (600kHz) - BH (10kHz)	-5.5	-3.0	-0.5	dB	
(frequency characteristics)		EQS = 2.7V or 3.3V					
ΔBHH (frequency characteristics)	ΔВНН	RFIN = VR, ΔBHH = BH (100kHz) - BH (10kHz) EQS = 2.2V, 1.8V, 1.5V, 1.1V, 0.7V	-5.5	-3.0	-0.5	dB	
REFL offset	REFLost	The difference with VR2 for REFL	-120	0	120	mV	
REFL gain 1	REFL1	A, B, C, D = V _{IN} , 10kHz, SGC = 1.3V, FBAL = VR2, GHS = 0V	8.5	11	13.5	dB	
REFL gain 2	REFL2	A, B, C, D = V _{IN} , 10kHz, SGC = 2V, FBAL = VR2, GHS = 0V	15.5	18.0	20.5	dB	
REFL gain UP	REFLGUP	GHS = 3.3V	+10.5	+14.0	+17.5	dB	
ΔREFL (frequency characteristics)	ΔREFL	A, C = V _{IN} , B, D = VR SGC = VR2, FBAL = VR2, GHS = 0V ΔREFL = REFL (100kHz) - REFL (10kHz)	-8.5	-6.0	-3.5	dB	
FE offset	FEost	The difference with VR2 for FE	-120	0	120	mV	
FE gain 1	FEG1	A, C = V _{IN} , 10kHz, B, D = VR SGC = 1.3V, FBAL = VR2, GHS = 0V	8.5	11.0	13.5	dB	
FE gain 2	FEG2	A, C = V _{IN} , 10kHz, B, D = VR SGC = 2V, FBAL = VR2, GHS = 0V	15.5	18.0	20.5	dB	
FE balance 1	FBAL1	A, C = V _{IN} , 10kHz, B, D = VR SGC = VR2, FBAL = 1.3V, GHS = 0V	15.5	18.0	20.5	dB	
FE balance 2	FBAL2	A, C = V _{IN} , 10kHz, B, D = VR SGC = VR2, FBAL = 2V, GHS = 0V	12.0	14.5	17.0	dB	
FE gain UP	FEGUP	GHS = 3.3V	+10.5	+14.0	+17.5	dB	
ΔFE (frequency characteristics)	ΔFE	A, C = V _{IN} , B, D = VR SGC = VR2, FBAL = VR2, GHS = 0V ΔFE = FE (130kHz) - FE (10kHz)	-8.5	-6.0	-3.5	dB	

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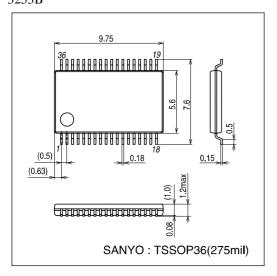
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Parameter	Symbol	nbol Conditions		Ratings		
Farameter	Symbol		min	typ	max	Unit
TE offset	TEost	The difference with VR2 for TE	-120	0	120	mV
TE gain 1	TEG1	$E = V_{IN}$, 10kHz, $F = VR$ SGC = 1.3V, TBAL = VR2, GHS = 0V	13.0	15.5	18.0	dB
TE gain 2	TEG2	$E = V_{IN}$, 10kHz, $F = VR$ SGC = 2V, TBAL = VR2, GHS = 0V	15.5	18.0	20.5	dB
TE balance 1	TBAL1	$E = V_{IN}$, 10kHz, $F = VR$ SGC = VR2, TBAL = 1.3V, GHS = 0V	15.5	18.0	20.5	dB
TE balance 2	TBAL2	$E = V_{IN}$, 10kHz, $F = VR$ SGC = VR2, TBAL = 2V, GHS = 0V	13.0	15.5	18.0	dB
TE gain UP	TEGUP	GHS = 3.3V	+10.5	+14.0	+17.5	dB
ΔTE (frequency characteristics)	ΔΤΕ	$E = V_{IN}, 10kHz, F = VR2$ $SGC = VR2, FBAL = VR2, GHS = 0V$ $\Delta TE = TE (150kHz) - TE (10kHz)$	-8.5	-6.0	-3.5	dB
TS offset	TSost	The difference with VR2 for TS	-120	0	120	mV
TS gain 1	TSG1	$E = V_{IN}$, 10kHz, $F = VR$ SGC = VR2, TBAL = VR2, GHS = 0V	13.0	15.5	18.0	dB
TS gain 2	TSG2	$E = V_{IN}$, 10kHz, $F = VR$ SGC = 1.3V, TBAL = VR2, GHS = 0V	9.0	11.5	14.0	dB
TS balance 1	TSBAL1	$E = V_{IN}$, 10kHz, $F = VR$ SGC = VR2, TBAL = 1.3V, GHS = 0V	14.0	16.5	19.0	dB
TS balance 2	TSBAL2	$E = V_{IN}$, 10kHz, $F = VR$ SGC = VR2, $TBAL = 2V$, $GHS = 0V$	11.5	14.0	16.5	dB
TS gain UP	TSGUP	GHS = 3.3V	+10.5	+14.0	+17.5	dB
ΔTS (frequency characteristics)	ΔΤS	$E = V_{IN}, F = VR$ $SGC = VR2, FBAL = VR2, GHS = 0V$ $\Delta TS = TS (250kHz) - TS (10kHz)$	-8.5	-6.0	-3.5	dB
CSS gain	CSS	A, D = V_{IN} , 10kHz, B, C = VR SGC = VR2, FBAL = VR2, GHS = 0V	14.0	16.5	19.0	dB
ΔCSS (frequency characteristics)	ΔCSS	A, D = V_{IN} , B, C = VR SGC = $VR2$, FBAL = $VR2$, GHS = $0V$ $\Delta CSS = CSS (100kHz) - CSS (10kHz)$	-5.5	-3.0	-0.5	dB
APC reference voltage 1	LDSL	The LDS voltage such that LDD becomes 3V LDON = 0V	160	190	220	mV
APC reference voltage 2	LDSH	The LDS voltage such that LDD becomes 3V LDON = 3.3V	180	230	280	mV
APC off voltage	LDD	LDON = VR	3.9	4.3	5	V

Package Dimensions

unit : mm 3253B



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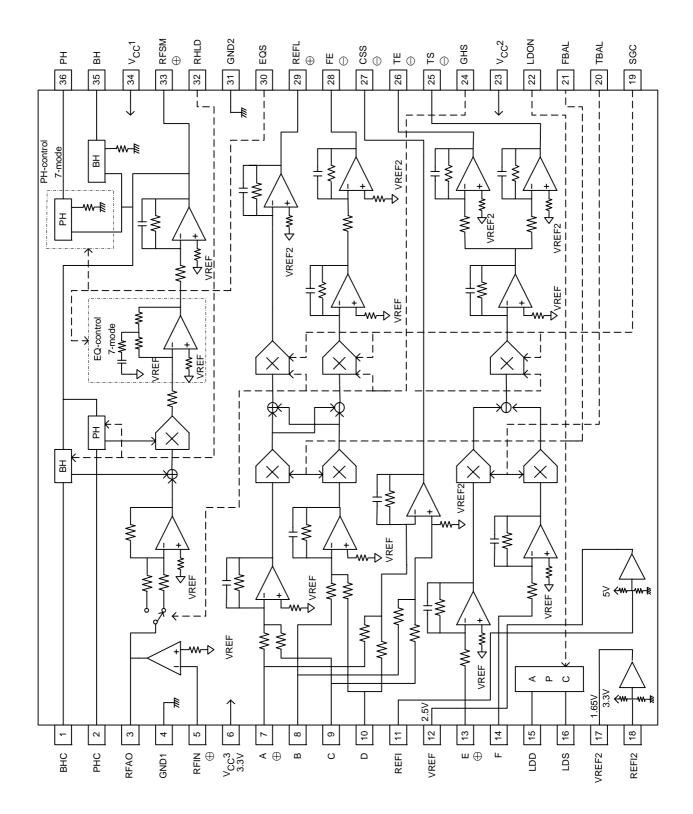
Pin Functions

Pin No.	Symbol	I/O	Description	
1	BHC		RF AGC detection bottom hold capacitor connection	
2	PHC		RF AGC detection peak hold capacitor connection	
3	RFAO	0	RF amplifier output	
4	GND1	I	RF signal system ground	
5	RFIN	I	Pickup voltage output connection. Inputs the RF addition signal from the pickup.	
6	V _{CC} 3	I	3.3V system V _{CC}	
7	Α	I	Pickup voltage output connection. Generates the FE, REFL, and CSS signals.	
8	В	I	Pickup voltage output connection. Generates the FE, REFL, and CSS signals.	
9	С	I	Pickup voltage output connection. Generates the FE, REFL, and CSS signals.	
10	D	I	Pickup voltage output connection. Generates the FE, REFL, and CSS signals.	
11	REFI		Reference voltage bypass capacitor connection	
12	VREF	0	Reference voltage output (Vref1 = 2.5V)	
13	Е	I	Pickup voltage output connection. Generates the TE and TS signals.	
14	F	I	Pickup voltage output connection. Generates the TE and TS signals.	
15	LDD	0	APC circuit output	
16	LDS	I	APC circuit input	
17	VREF2	0	Reference voltage output (Vref2 = 1.65V)	
18	REFI2		Reference voltage bypass capacitor connection	
19	SGC	I	Servo gain control (FE, TE, TS, and REFL signals)	
20	TBAL	I	TE balance adjustment (TE and TS signals)	
21	FBAL	I	FE balance adjustment (FE signal)	
22	LDON	I	Laser on/off, laser power increase control	
23	V _{CC} 2	I	Servo signal system V _{CC} (5V)	
24	GHS	I	RF and servo signal gain switch (0dB or +14dB)	
25	TS	0	TS signal (used for the TES signal) output (to the DSP)	
26	TE	0	TE signal output (to the DSP)	
27	CSS	0	Center servo signal output (to the DSP)	
28	FE	0	FE signal output (to the DSP)	
29	REFL	0	Reflection signal output (to the DSP)	
30	EQS	I	RF equalizer and PH detection time constant control	
31	GND2	I	Servo signal system ground	
32	RHLD	I	RF hold control	
33	RFSM	0	EFM signal output (to the DSP)	
34	V _{CC} 1	I	RF signal system V _{CC} (5V)	
35	ВН	0	RF bottom hold signal output (to the DSP)	
36	PH	0	RF peak hold signal output (to the DSP)	

Usage Notes

The signal levels of the inputs to the A (pin 7), B (pin 8), C (pin 9), D (pin 10), E (pin 13), and F (pin 14) pins must be set up to be above the reference voltage (VREF).

Block Diagram



 \bigoplus \leftarrow These symbols indicate the phase relationship.

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